

8961726 TEXAS INSTR (OPTO)

62C 36760

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TIP31, TIP31A, TIP31B, TIP31C,

TIP31D, TIP31E, TIP31F

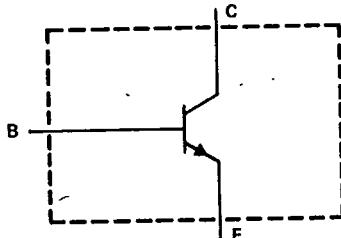
N-P-N SILICON POWER TRANSISTORS

DECEMBER 1970 - REVISED OCTOBER 1984

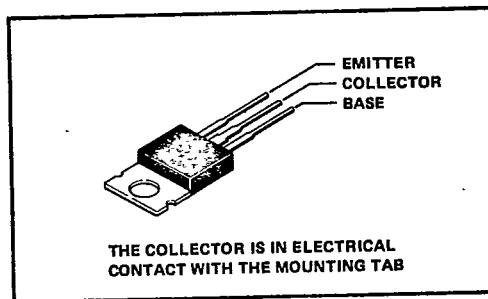
- 40 W at 25°C Case Temperature
- 3 A Continuous Collector Current
- 5 A Peak Collector Current
- Minimum f_T of 3 MHz at 10 V, 0.5 mA
- Customer-Specified Selections Available

7-33-11

device schematic



TO-220AB PACKAGE



absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	TIP31	TIP31A	TIP31B	TIP31C
Collector-base voltage	80 V	100 V	120 V	140 V
Collector-emitter voltage ($I_B = 0$)	40 V	60 V	80 V	100 V
Emitter-base voltage			5 V	
Continuous collector current			3 A	
Peak collector current (see Note 1)			5 A	
Continuous base current			1 A	
Safe operating area at 25°C case temperature			See Figure 4	
Continuous device dissipation at (or below) 25°C case temperature (see Note 2)			40 W	
Continuous device dissipation at (or below) 25°C free-air temperature (see Note 3)			2 W	
Unclamped inductive load energy (see Note 4)			32 mJ	
Operating collector junction and storage temperature range			-65°C to 150°C	
Lead temperature 3.2 mm (0.125 inch) from case for 10 seconds			250°C	

- NOTES:
1. This value applies for $t_{sw} \leq 0.3$ ms, duty cycle $\leq 10\%$.
 2. Derate linearly to 150°C case temperature at the rate of 0.32 W/°C.
 3. Derate linearly to 150°C free-air temperature at the rate of 16 mW/°C.
 4. This rating is based on the capability of the transistor to operate safely in the circuit in Figure 2.

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TIP Devices

TEXAS
INSTRUMENTS

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TIP31, TIP31A, TIP31B, TIP31C,
 TIP31D, TIP31E, TIP31F
 N-P-N SILICON POWER TRANSISTORS

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absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	TIP31D	TIP31E	TIP31F
Collector-base voltage	160 V	180 V	200 V
Collector-emitter voltage ($I_B = 0$)	120 V	140 V	160 V
Emitter-base voltage	5 V		
Continuous collector current	3 A		
Peak collector current (see Note 1)	5 A		
Continuous base current	1 A		
Safe operating area at 25°C case temperature	See Figure 4		
Continuous device dissipation at (or below) 25°C case temperature (see Note 2)	40 W		
Continuous device dissipation at (or below) 25°C free-air temperature (see Note 3)	2 W		
Unclamped inductive load energy (see Note 4)	32 mJ		
Operating collector junction and storage temperature range	-65°C to 150°C		
Lead temperature 3.2 mm (0.125 inch) from case for 10 seconds	250°C		

- NOTES: 1. This value applies for $t_W \leq 0.3$ ms, duty cycle $\leq 10\%$.
 2. Derate linearly to 150°C case temperature at the rate of 0.32 W/°C.
 3. Derate linearly to 150°C free-air temperature at the rate of 16 mW/°C.
 4. This rating is based on the capability of the transistor to operate safely in the circuit in Figure 2.

electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TIP31			TIP31A			TIP31B			TIP31C			UNIT
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
$V_{(BR)CEO}$	$I_C = 30$ mA, $I_B = 0$, See Note 5	40			60			80			100			V
I_{CEO}	$V_{CE} = 30$ V, $I_B = 0$		0.3			0.3								mA
	$V_{CE} = 60$ V, $I_B = 0$								0.3		0.3			mA
I_{CES}	$V_{CE} = 80$ V, $V_{BE} = 0$		0.2						0.2					mA
	$V_{CE} = 100$ V, $V_{BE} = 0$					0.2								mA
	$V_{CE} = 120$ V, $V_{BE} = 0$								0.2					mA
	$V_{CE} = 140$ V, $V_{BE} = 0$										0.2			mA
I_{EBO}	$V_{EB} = 5$ V, $I_C = 0$		1			1			1		1			mA
	$V_{CE} = 4$ V, $I_C = 1$ A, See Notes 5 and 6	25			25			25			25			
hFE	$V_{CE} = 4$ V, $I_C = 3$ A, See Notes 5 and 6	10	50		10	50		10	50		10	50		
V_{BE}	$V_{CE} = 4$ V, $I_C = 3$ A, See Notes 5 and 6		1.8			1.8			1.8		1.8			V
$V_{CE(sat)}$	$I_B = 375$ mA, $I_C = 3$ A, See Notes 5 and 6		1.2			1.2			1.2		1.2			V
h_{fe}	$V_{CE} = 10$ V, $I_C = 0.5$ A, $f = 1$ kHz	20			20			20			20			
h_{fe}	$V_{CE} = 10$ V, $I_C = 0.5$ A, $f = 1$ MHz	3			3			3			3			

- NOTES: 5. These parameters must be measured using pulse techniques, $t_W = 300$ μ s, duty cycle $\leq 2\%$.
 6. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

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electrical characteristics at 25°C case temperature (unless otherwise noted)

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PARAMETER	TEST CONDITIONS	TIP31D	TIP31E	TIP31F	UNIT
		MIN	TYP	MAX	
$V_{(BR)CEO}$	$I_C = 30 \text{ mA}, I_B = 0,$ See Note 5	120	140	160	V
I_{CEO}	$V_{CE} = 90 \text{ V}, I_B = 0$	0.3	0.3	0.3	mA
I_{CES}	$V_{CE} = 160 \text{ V}, V_{BE} = 0$	0.2			
	$V_{CE} = 180 \text{ V}, V_{BE} = 0$		0.2		mA
	$V_{CE} = 200 \text{ V}, V_{BE} = 0$			0.2	
I_{EB0}	$V_{EB} = 5 \text{ V}, I_C = 0$	1	1	1	mA
h_{FE}	$V_{CE} = 4 \text{ V}, I_C = 1 \text{ A},$ See Notes 5 and 6	25	25	25	
	$V_{CE} = 4 \text{ V}, I_C = 3 \text{ A},$ See Notes 5 and 6	5	5	5	
V_{BE}	$V_{CE} = 4 \text{ V}, I_C = 3 \text{ A},$ See Notes 5 and 6	1.8	1.8	1.8	V
$V_{CE(sat)}$	$I_B = 750 \text{ mA}, I_C = 3 \text{ A},$ See Notes 5 and 6	2.5	2.5	2.5	V
$h_{f\alpha}$	$V_{CE} = 10 \text{ V}, I_C = 0.5 \text{ A},$ $f = 1 \text{ kHz}$	20	20	20	
$h_{f\beta}$	$V_{CE} = 10 \text{ V}, I_C = 0.5 \text{ A},$ $f = 1 \text{ MHz}$	3	3	3	

NOTES: 5. These parameters must be measured using pulse techniques, $t_w = 300 \mu\text{s}$, duty cycle $\leq 2\%$.

6. These parameters are measured using voltage-sensing contacts separate from the current-carrying contacts.

thermal characteristics

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
$R_{\theta JC}$			3.125		°C/W
$R_{\theta JA}$			62.5		

resistive-load switching characteristic at 25°C case temperature (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	MIN	TYP	MAX	UNIT
		0.5	2	μs	
t_{on}	$I_C = 1 \text{ A}, I_{B1} = 0.1 \text{ A}, I_{B2} = -0.1 \text{ A},$				
t_{off}	$V_{BE(\text{off})} = -4.3 \text{ V}, R_L = 30 \Omega,$ See Figure 1				

† Voltage and current values shown are nominal; exact values vary slightly with transistor parameters.

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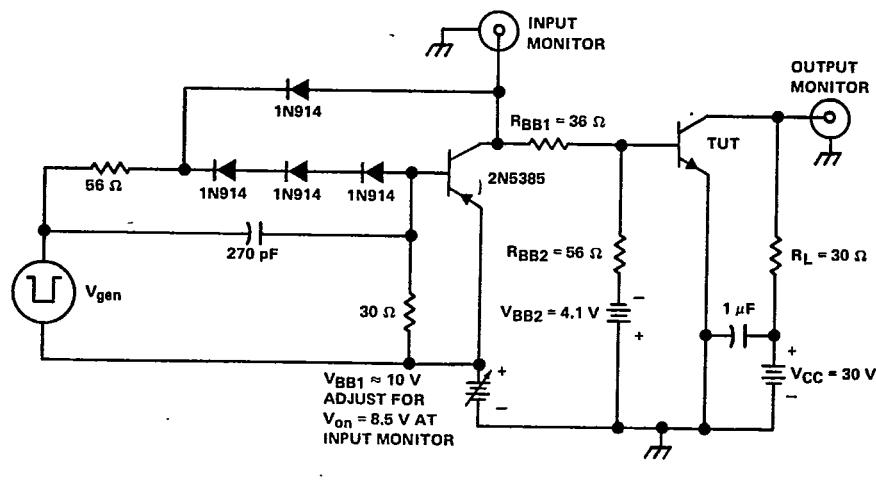
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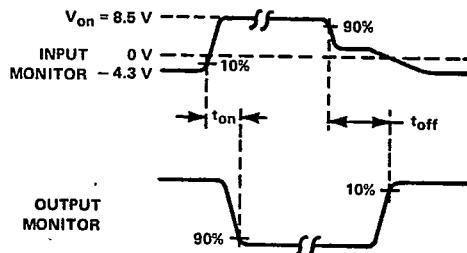
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PARAMETER MEASUREMENT INFORMATION



TEST CIRCUIT



VOLTAGE WAVEFORMS

- NOTES:
- V_{gen} is a -30-V pulse into a $50\ \Omega$ termination.
 - The V_{gen} waveform is supplied by the following characteristics: $t_r \leq 15\ \text{ns}$, $t_f \leq 15\ \text{ns}$, $Z_{out} = 50\ \Omega$, $t_w = 20\ \mu\text{s}$, duty cycle $\leq 2\%$.
 - Waveforms are monitored on an oscilloscope with the following characteristics: $t_r \leq 15\ \text{ns}$, $R_{in} \geq 10\ M\Omega$, $C_{in} \leq 11.5\ \mu\text{F}$.
 - Resistors must be noninductive types.
 - The d-c power supplies may require additional bypassing in order to minimize ringing.

FIGURE 1. RESISTIVE-LOAD SWITCHING

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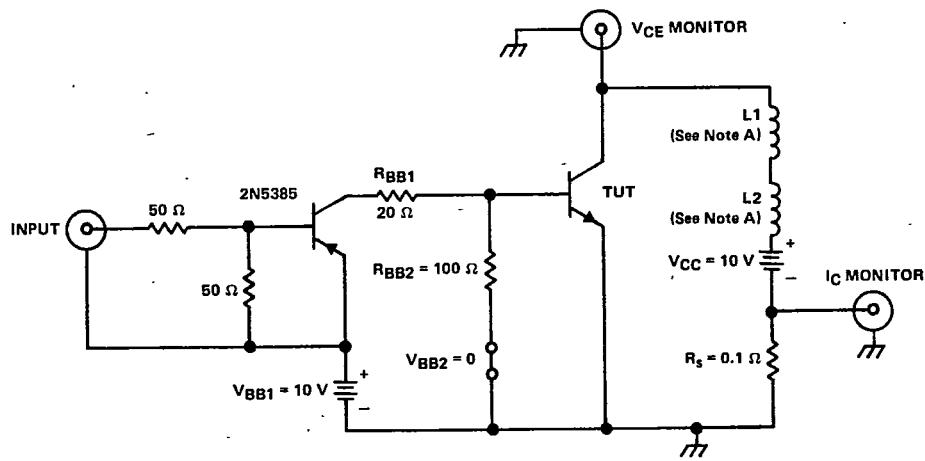
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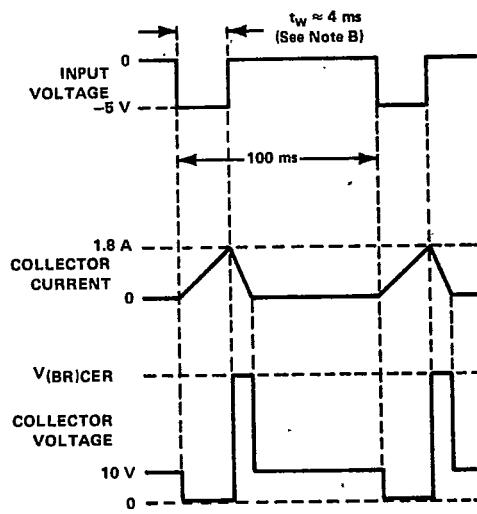
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PARAMETER MEASUREMENT INFORMATION

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TEST CIRCUIT



VOLTAGE AND CURRENT WAVEFORMS

NOTES: A. L1 and L2 are 10 mH, 0.11 Ω, Chicago Standard Transformer Corporation C-2688, or equivalent.
 B. Input pulse duration is increased until $i_{CM} = 1.8 \text{ A}$.

FIGURE 2. INDUCTIVE-LOAD SWITCHING

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TYPICAL CHARACTERISTICS

STATIC FORWARD CURRENT TRANSFER RATIO
 VS
 COLLECTOR CURRENT

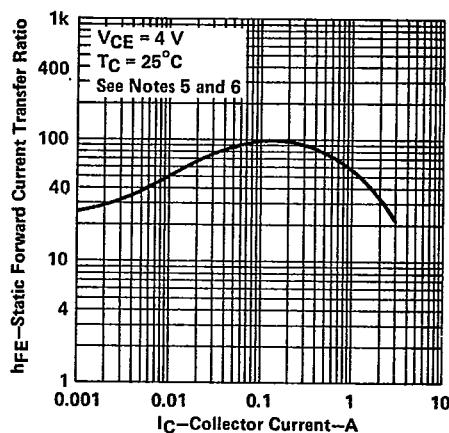


FIGURE 3

- NOTES: 5. These parameters must be measured using pulse techniques, $t_w = 300 \mu s$, duty cycle $\leq 2\%$.
 6. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

MAXIMUM SAFE OPERATING AREA

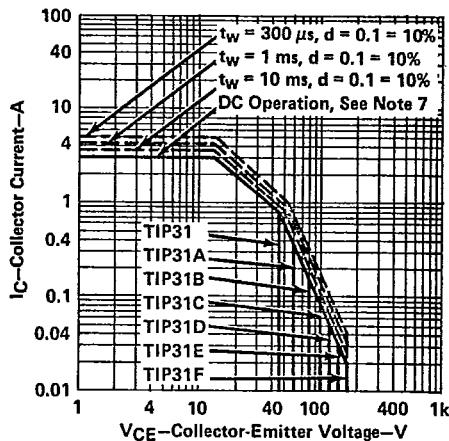


FIGURE 4

- NOTE 7: This combination of maximum voltage and current may be achieved only when switching from saturation to cutoff with a clamped inductive load.

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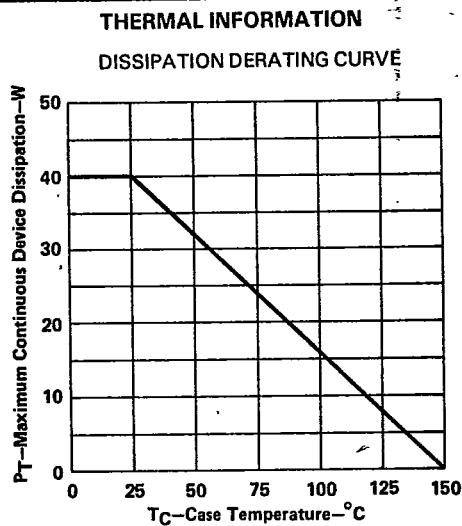


FIGURE 5

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